

MOSFET - Power, Single N-Channel 80 V, 10 mΩ, 61 A

NTMFSC010N08M7

Features

- DUAL COOL Top Side Cooling PQFN Package
- Max $r_{DS(on)} = 10 \text{ m}\Omega$ at $V_{GS} = 10 \text{ V}$, $I_D = 10 \text{ A}$
- High Performance Technology for Extremely Low r_{DS(on)}
- 100% UIL Tested
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

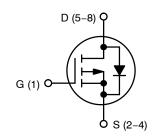
Parameter		Symbol	Value	Unit		
Drain-to-Source Voltage			V_{DSS}	80	V	
Gate-to-Source Voltage			V _{GS}	±20	V	
Continuous Drain	Steady State	T _C = 25°C	I _D	61	Α	
Current R _{θJC} (Notes 1, 3)	State	T _C = 100°C		38.6		
Power Dissipation		T _C = 25°C	P_{D}	78.1	W	
R _{θJC} (Note 1)		T _C = 100°C		31.2		
Continuous Drain Current R _{0.1A}	Steady State	T _A = 25°C	I _D	12.5	Α	
(Notes 1, 2, 3)	State	T _A = 100°C		7.9		
Power Dissipation		T _A = 25°C	P_{D}	3.3	W	
R _{θJA} (Notes 1, 2)		T _A = 100°C		1.3		
Pulsed Drain Current	$T_A = 25$	°C, t _p = 10 μs	I _{DM}	180	Α	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	ç	
Source Current (Body Diode)			I _S	61	Α	
Single Pulse Drain-to-Source Avalanche Energy (I _{L(pk)} = 3.9 A)			E _{AS}	640	mJ	
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			T _L	260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 1 in² pad size, 1 oz Cu pad.
- Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX		
80 V	10 mΩ @ 10 V	61 A		

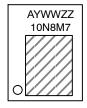
N-Channel MOSFET





DFN8 5x6 (Dual Cool 56) CASE 506EG

MARKING DIAGRAM



A = Assembly Location

= Year

WW = Work Week
ZZ = Lot Traceability

10N8M7 = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping		
NTMFSC010N08M7	DFN8 (Pb-Free)	3000 / Tape & Reel		

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•	•					•
Drain to Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		80			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				49		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 80 V	T _J = 25°C			1	μΑ
Zero Gate Voltage Drain Current	I _{GSS}	V _{DS} = 0 V, V _{GS} =	± 20 V			±100	nA
ON CHARACTERISTICS (Note 4)					•		
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$, $I_D = 1$	120 μΑ	2.5	3.3	4.5	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-9		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 10 A		7.6	10	mΩ
Forward Transconductance	gFS	V _{DS} = 5 V	I _D = 10 A		21.5	40	S
CHARGES, CAPACITANCES & GATE F	RESISTANCE		•		•		
Input Capacitance	C _{iss}	V _{GS} = 0 V, f = 1 MHz	V _{DS} = 0 V		2373		pF
	C _{iss}		V _{DS} = 40 V		2080	2700	
Output Capacitance	C _{oss}				286	430	
Reverse Transfer Capacitance	C _{rss}				11	17	
Diode Capacitance	C _{diode}				275		
Gate Resistance	R _g	V _{GS} = 0.5 V, f = 1	1MHz		0.6	4	Ω
Gate Charge (1V)	Q _{G(1V)}	V _{GS} = 0 to 1 V	V _{DS} = 40 V;		2.1		nC
Threshold Gate Charge	Q _{g(th)}	V _{GS} = 0 to 2 V	I _D = 10 A		4.3		1
Gate Charge (3V)	Q _{G(3V)}	V _{GS} = 0 to 3 V		6.4			
Gate Charge (4V)	Q _{G(4V)}	V _{GS} = 0 to 4 V	1		8.6		
Gate Charge (5V)	Q _{G(5V)}	V _{GS} = 0 to 5 V	1		9.6		
Gate Charge (6V)	Q _{G(6V)}	V _{GS} = 0 to 6 V	1		18.7		
Gate Charge (7V)	Q _{G(7V)}	V _{GS} = 0 to 7 V	1		21.3		
Gate Charge (8V)	Q _{G(8V)}	V _{GS} = 0 to 8 V	1		24		
Gate Charge (9V)	Q _{G(9V)}	V _{GS} = 0 to 9 V	1		26.6		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 0 to 10 V	1		29.3	38	
Gate to Source Gate Charge	Q _{gs}	V _{DS} = 40 V, I _D = 10 A			11.8		
Gate to Drain "Miller" Charge	Q _{gd}				4.3		
Switching Charge	Q _{sw}				13.1		
Plateau Voltage	V _{GP}				5.5		V
Output Charge	Q _{oss}	V _{DS} = 40 V _, V _{GS} = 0 V			26		nC
SWITCHING CHARACTERISTICS (Note	= 5)						
Turn-On Delay Time	t _{d(ON)}	V_{DD} = 40 V, I_{D} = 10 A, V_{GS} = 10 V, R_{GEN} = 6 Ω			14		ns
Turn-On Rise Time	t _r				6		ns
Turn-Off Delay Time	t _{d(OFF)}				27		ns
Turn-Off Fall Time	t _f				6		ns
DRAIN – SOURCE DIODE CHARACTE	RISTICS						
Source to Drain Diode Voltage	V _{SD}	I _{SD} = 10 A, V _{GS}	= 0 V		0.82	1.2	V
		· · · · · · · · · · · · · · · · · · ·		·		·	

^{4.} Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.
5. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_{.I} = 25°C unless otherwise noted)

Parameter	Symbol	Test Condition	Min	Тур	Max	Unit			
DRAIN – SOURCE DIODE CHARACTERISTICS									
Reverse Recovery Time	T _{RR}	$V_{GS} = 0 \text{ V, } dI_{SD}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 10 \text{ A}$		41	50	ns			
Charge Time	t _a	I _S = 10 A		24.6					
Discharge Time	t _b			16.1					
Reverse Recovery Charge	Q _{RR}			45	58	nC			

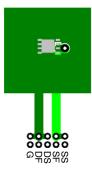
- Pulse Test: pulse width ≤ 300 µs, duty cycle ≤ 2%.
- 5. Switching characteristics are independent of operating junction temperatures.

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

THERMAL CHARACTERISTICS

Symbol	Parameter		Value	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case	(Top Source)	1.6	
$R_{ heta JC}$	Thermal Resistance, Junction to Case	(Bottom Drain)	3.0	
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient	(Note 1a)	38	
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient	(Note 1b)	81	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1c)	27	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1d)	34	
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient	(Note 1e)	16	0000
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient	(Note 1f)	19	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1g)	26	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1h)	61	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1i)	16	
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient	(Note 1j)	23	
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient	(Note 1k)	11	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	(Note 1I)	13	

 R_{θJA} is determined with the device mounted on a FR-4 board using a specified pad of 2 oz copper as shown below. R_{θJA} is guaranteed by design while R_{CA} is determined by the user's board design.



a) 38°C/W when mounted on a 1 in2 pad of 2 oz copper.



b) 81°C/W when mounted on a minimum pad of 2 oz copper.

- c) Still air, 20.9·10.4·12.7 mm Aluminum Heat Sink, 1 in2 pad of 2 oz copper
- d) Still air, 20.9·10.4·12.7 mm Aluminum Heat Sink, minimum pad of 2 oz copper
- e) Still air, 45.2-41.4-11.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, 1 in2 pad of 2 oz copper
- f) Still air, 45.2-41.4-11.7 mm Aavid Thermalloy Part # 10-L41B-11 Heat Sink, minimum pad of 2 oz copper
- g) .200FPM Airflow, No Heat Sink, 1 in2 pad of 2 oz copper
- h) .200FPM Airflow, No Heat Sink, minimum pad of 2 oz copper
- i) .200FPM Airflow, 20.9 10.4 12.7 mm Aluminum Heat Sink, 1 in2 pad of 2 oz copper
- j) .200FPM Airflow, 20.9 10.4 12.7 mm Aluminum Heat Sink, minimum pad of 2 oz copper
- k) .200FPM Airflow, 45.2-41.4-11.7 mm Aavid Thermalloy Part # 10 L41B 11 Heat Sink, 1 in 2 pad of 2 oz copper
- 1) .200FPM Airflow, 45.2-41.4-11.7 mm Aavid Thermalloy Part # 10 L41B 11 Heat Sink, minimum pad of 2 oz copper
- 7. Pulse Test: Pulse Width < 300 _s, Duty cycle < 2.0%.

TYPICAL CHARACTERISTICS

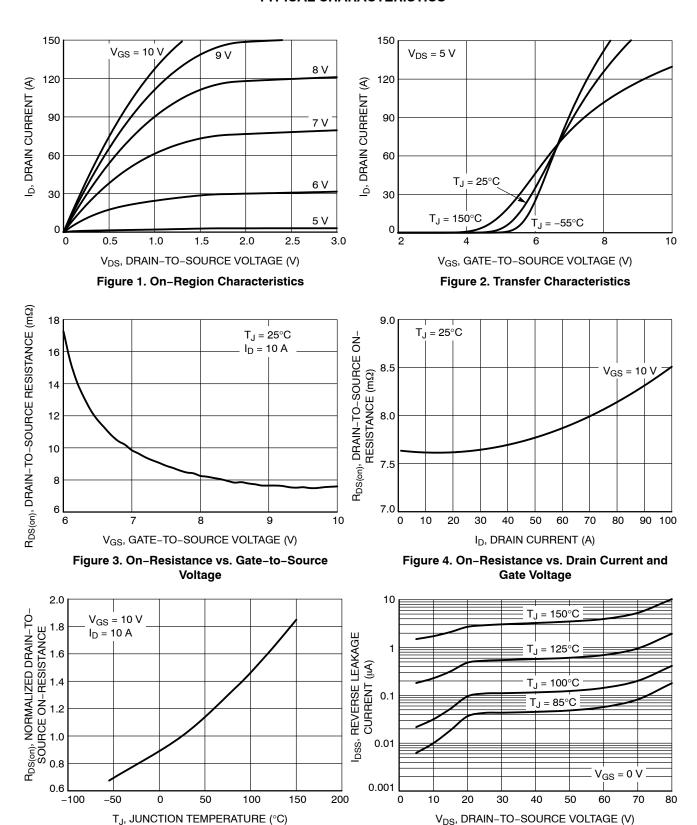


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

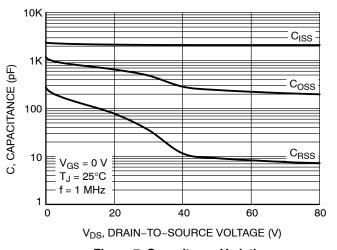


Figure 7. Capacitance Variation

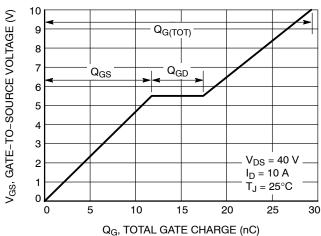


Figure 8. Gate-to-Source and Drain-to-Source Voltage vs. Total Charge

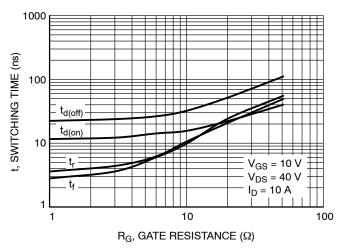


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

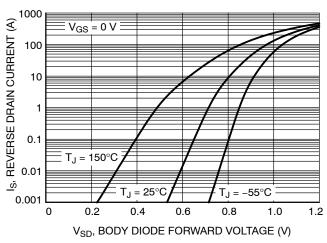


Figure 10. Diode Forward Voltage vs. Current

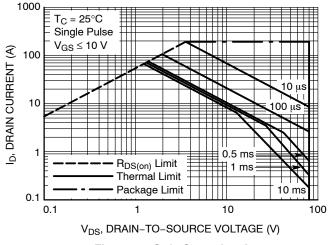


Figure 11. Safe Operating Area

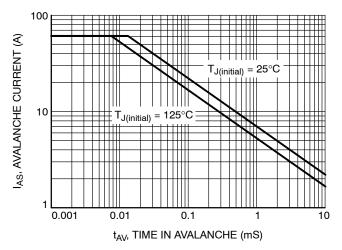


Figure 12. $I_{\mbox{\scriptsize PEAK}}$ vs. Time in Avalanche

TYPICAL CHARACTERISTICS

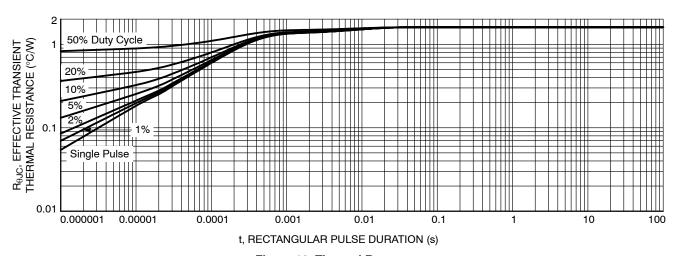
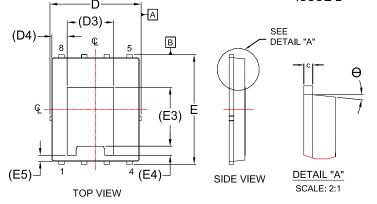


Figure 13. Thermal Response

PACKAGE DIMENSIONS

DFN8 5.1x6.15, 1.27P, DUAL COOL

CASE 506EG ISSUE D



// 0.10 C

NOTES:

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- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- 3. COPLANARITY APPLIES TO THE EXPOSED PADS AS WELL AS THE TERMINALS.
- DIMENSIONS D1 AND E1 DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR GATE BURRS.
- SEATING PLANE IS DEFINED BY THE TERMINALS.
 "A1" IS DEFINED AS THE DISTANCE FROM THE SEATING PLANE TO THE LOWEST POINT ON THE PACKAGE BODY.

DIM

Α

A1

A2

h

b1

С

D

D₁

D2

D3

D4

E E1

E2

E3

E4

E5

E6

E7

1/2e

e

K

L1

θ

MIN.

0.85

0.31

0.21

0.20

4.90

4.80

3.67

6.05

5.70

3.38

1.30

0.56

0.52

0°

MILLIMETERS

NOM

0.90

0.41

0.31

0.25

5.00

4.90

3.82

2.60 REF

0.86 REF

6.15

5.80

3.48

3.30 REF

0.50 REF

0.34 REF

0.30 REF

0.52 REF

1.27 BSC

0.635 BSC

1.40

0.66

0.62

MAX.

0.95

0.05

0.05

0.51

0.41

0.30

5.10

5.00

3.97

6.25

5.90

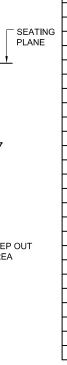
3.58

1.50

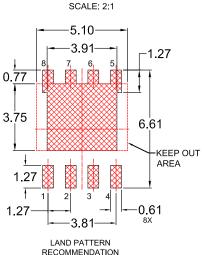
0.76

0.72

12°



L1



A2

DETAIL "B"

*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

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